

**Notice of References Cited**

Application/Control No.

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Applicant(s)/Patent Under

Reexamination

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Examiner

Hoang-Vu A. Nguyen-Ba

Art Unit

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*	B US-7,076,478	07-2006	O'Rourke et al.	707/3
*	C US-2004/0193727	09-2004	Varga et al.	709/238
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**NON-PATENT DOCUMENTS**

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